Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/701,306	JUNG, HEA SUK
Examiner	Art Unit
Linh M. Nauven	2816

	SEARCHED					
Class	Subclass	Date	Examiner			
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INT	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			
Interference Jeanh History		05/09/06	41			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
DATE	EXMR			
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